

## P-Ch 60V Fast Switching MOSFETs



### Features

- Split Gate Trench MOSFET technology
- Excellent package for heat dissipation
- High density cell design for low  $R_{DS(ON)}$

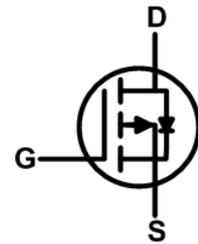
### Applications

- DC-DC Converters
- Power management functions
- Synchronous-rectification applications

### Product Summary

BVDSS	RDSON	ID
-60V	42mΩ	-10A

### SOP8 Pin Configuration



### Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	-60	V
$V_{GS}$	Gate-Source Voltage	±20	V
$I_D@T_C=25^\circ C$	Continuous Drain Current, $V_{GS}$ @ 10V <sup>1,6</sup>	-10	A
$I_D@T_C=100^\circ C$	Continuous Drain Current, $V_{GS}$ @ 10V <sup>1,6</sup>	-5	A
$I_{DM}$	Pulsed Drain Current <sup>2</sup>	-40	A
EAS	Single Pulse Avalanche Energy <sup>3</sup>	48	mJ
$I_{AS}$	Avalanche Current	---	A
$P_D@T_C=25^\circ C$	Total Power Dissipation <sup>4</sup>	40	W
$T_{STG}$	Storage Temperature Range	-55 to 150	°C
$T_J$	Operating Junction Temperature Range	-55 to 150	°C

### Thermal Data

Symbol	Parameter	Typ.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction-Ambient <sup>1</sup>	---	---	°C/W
$R_{\theta JC}$	Thermal Resistance Junction-Case <sup>1</sup>	---	3.12	°C/W

### Electrical Characteristics ( $T_J=25^\circ\text{C}$ , unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=-250\mu A$	-100	---	---	V
$\Delta BV_{DSS}/\Delta T_J$	$BV_{DSS}$ Temperature Coefficient	Reference to $25^\circ\text{C}$ , $I_D=1\text{mA}$	---	---	---	$V/^\circ\text{C}$
$R_{DS(ON)}$	Static Drain-Source On-Resistance <sup>2</sup>	$V_{GS}=-10V, I_D=-4A$	---	42	54	m $\Omega$
		$V_{GS}=-4.5V, I_D=-2A$	---	54	77	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}, I_D=-250\mu A$	-1.3	-1.8	-2.3	V
$\Delta V_{GS(th)}$	$V_{GS(th)}$ Temperature Coefficient		---	---	---	$\text{mV}/^\circ\text{C}$
$I_{DSS}$	Drain-Source Leakage Current	$V_{DS}=-60V, V_{GS}=0V, T_J=25^\circ\text{C}$	---	---	1	$\mu\text{A}$
		$V_{DS}=-60V, V_{GS}=0V, T_J=100^\circ\text{C}$	---	---	---	
$I_{GSS}$	Gate-Source Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0V$	---	---	$\pm 100$	nA
$g_{fs}$	Forward Transconductance	$V_{DS}=-5V, I_D=-6A$	---	---	---	S
$R_g$	Gate Resistance	$V_{DS}=0V, V_{GS}=0V, f=1\text{MHz}$	---	5	---	$\Omega$
$Q_g$	Total Gate Charge	$V_{DS}=-30V, V_{GS}=-10V, I_D=-4A$	---	11.6	---	nC
$Q_{gs}$	Gate-Source Charge		---	2.4	---	
$Q_{gd}$	Gate-Drain Charge		---	1.5	---	
$T_{d(on)}$	Turn-On Delay Time	$V_{GS}=-10V, V_{DD}=-30V,$ $R_G=3\Omega, I_D=-4A$	---	10	---	ns
$T_r$	Rise Time		---	6	---	
$T_{d(off)}$	Turn-Off Delay Time		---	40	---	
$T_f$	Fall Time		---	13	---	
$C_{iss}$	Input Capacitance	$V_{DS}=-30V, V_{GS}=0V, f=1\text{MHz}$	---	667	---	$\mu\text{F}$
$C_{oss}$	Output Capacitance		---	114	---	
$C_{rss}$	Reverse Transfer Capacitance		---	5.2	---	

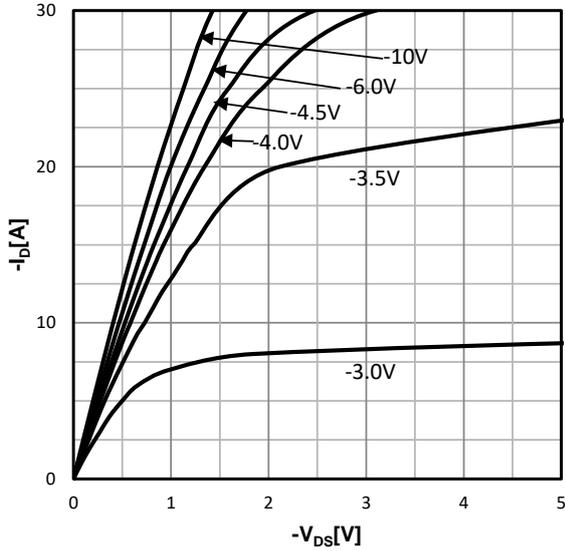
### Diode Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$I_S$	Continuous Source Current <sup>1,4</sup>	$V_G=V_D=0V$ , Force Current	---	---	-10	A
$V_{SD}$	Diode Forward Voltage <sup>2</sup>	$V_{GS}=0V, I_S=-4A, T_J=25^\circ\text{C}$	---	---	-1.2	V
$t_{rr}$	Reverse Recovery Time	$I_F=-4A, di/dt=100A/\mu\text{s}$ ,	---	28	---	nS
$Q_{rr}$	Reverse Recovery Charge	$T_J=25^\circ\text{C}, V_{DD}=-30V$	---	40	---	nC

a1: Repetitive rating; pulse width limited by maximum junction temperature  
a2:  $V_{DD}=-30V, L=0.3\text{mH}, R_G=25\Omega$ , Starting  $T_J=25^\circ\text{C}$

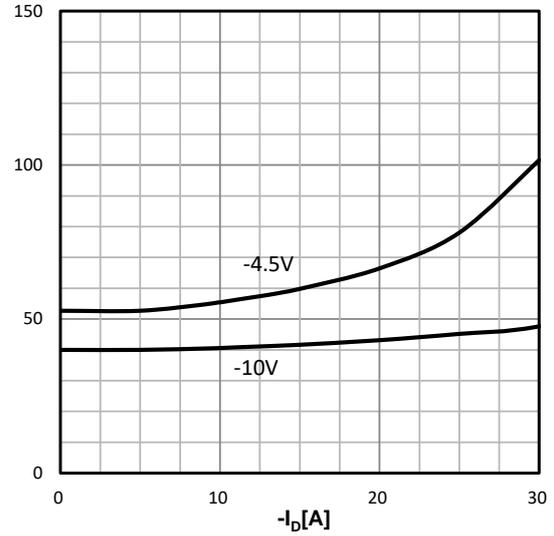
### General Description:

Figure 1: Typ. output characteristics



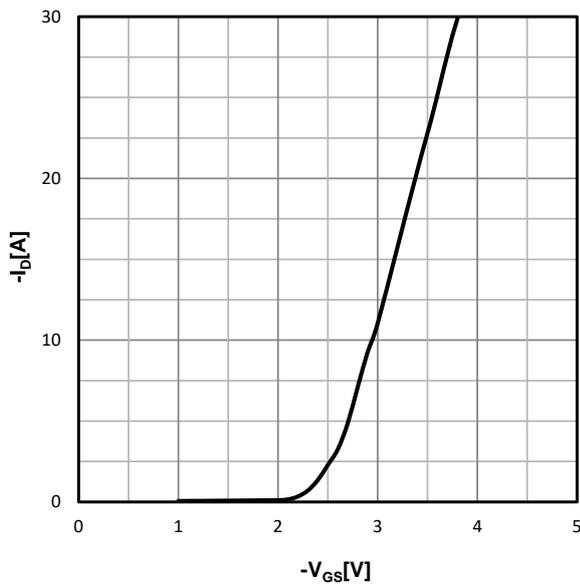
$$I_D = f(V_{DS}), T_j = 25^\circ\text{C}; \text{ parameter: } V_{GS}$$

Figure 2: Typ. drain-source on resistance



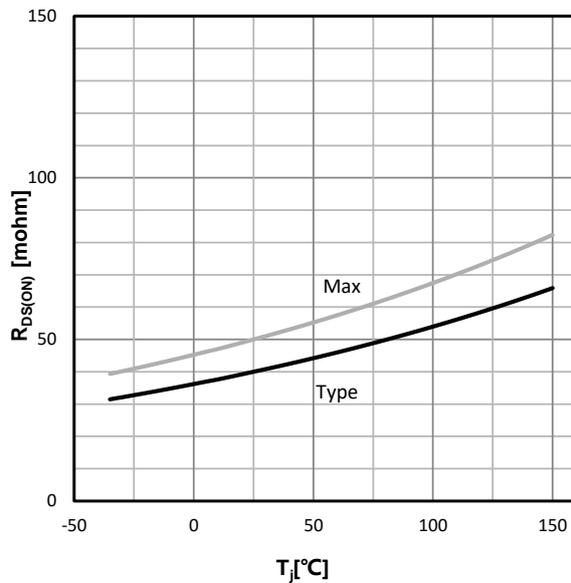
$$R_{DS(on)} = f(I_D), T_j = 25^\circ\text{C}; \text{ parameter: } V_{GS}$$

Figure 3: Typ. transfer characteristics



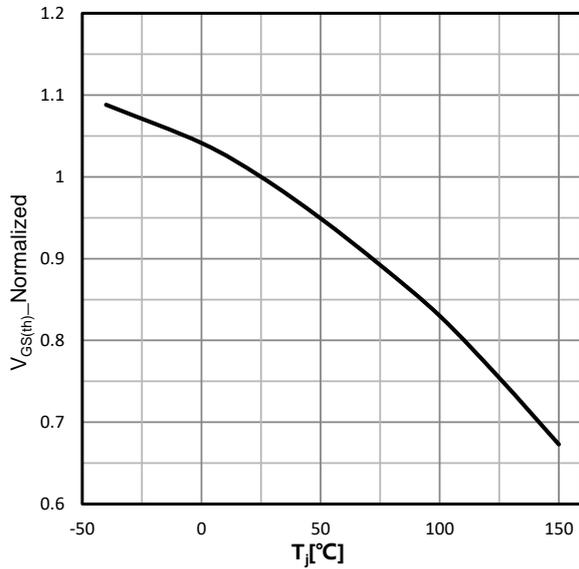
$$I_D = f(V_{GS}), |V_{DS}| > 2|I_D|R_{DS(on)max};$$

Figure 4: drain-source on resistance



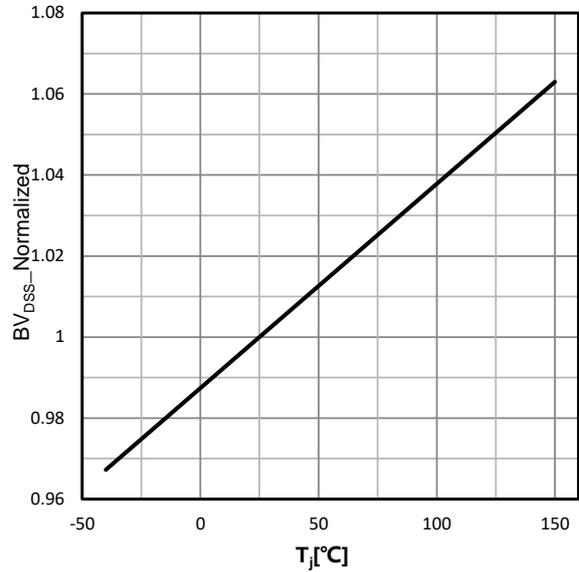
$$R_{DS(on)} = f(T_j), I_D = -10\text{A}, V_{GS} = -10\text{V};$$

**Figure 5: Typ. gate threshold voltage**



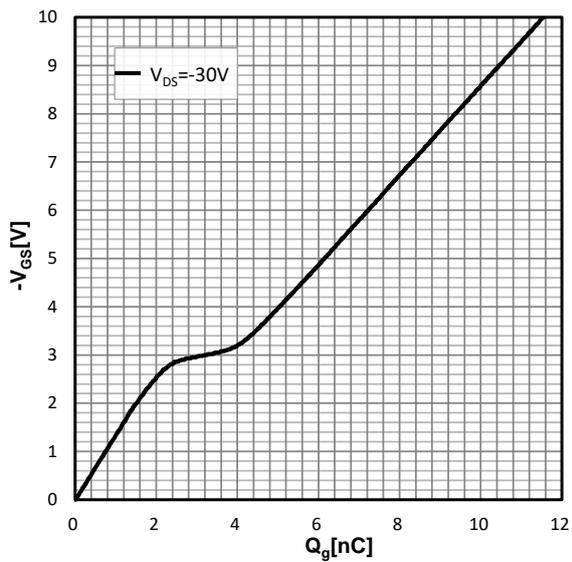
$$V_{GS} = f(T_j), V_{GS} = V_{DS}, I_D = -250 \mu\text{A};$$

**Figure 6: Drain-source breakdown voltage**



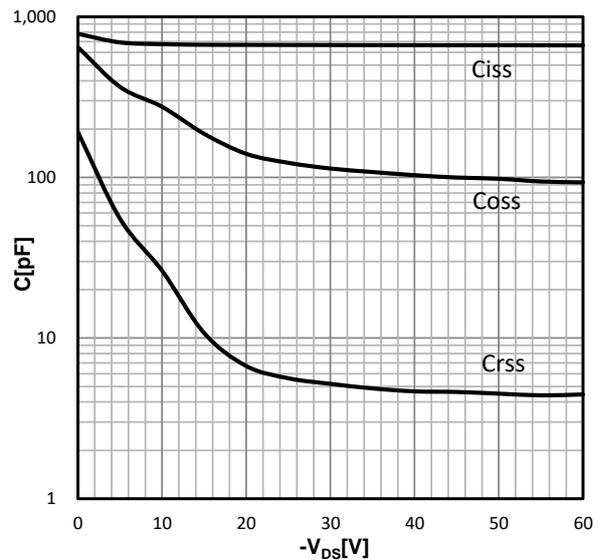
$$V_{BR(DSS)} = f(T_j); I_D = -250 \mu\text{A};$$

**Figure 7: Typ. gate charge**



$$V_{GS} = f(Q_g), I_D = -10\text{A}, T_j = 25^{\circ}\text{C}; \text{ parameter: } V_{DS}$$

**Figure 8: Typ. Capacitances**



$$C = f(V_{DS}); V_{GS} = 0\text{V}; f = 1.0 \text{ MHz};$$

Figure 9: Power dissipation

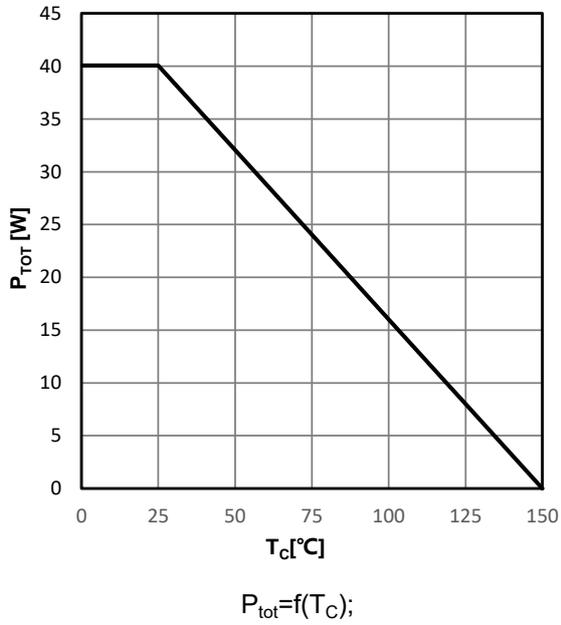


Figure 10: Drain current

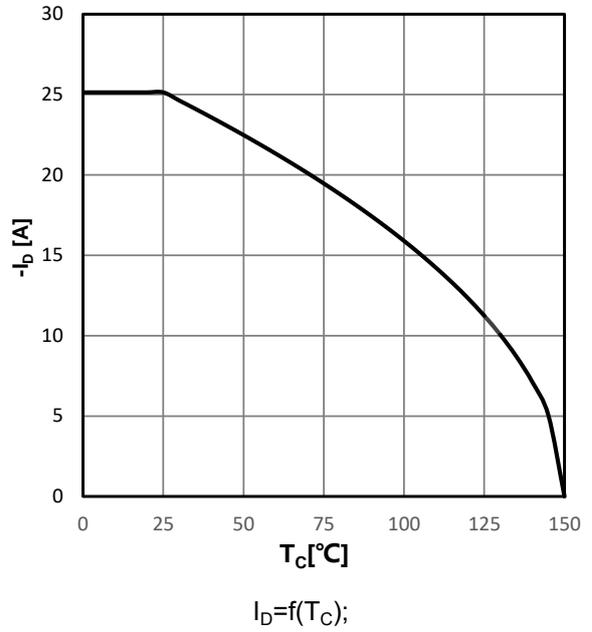
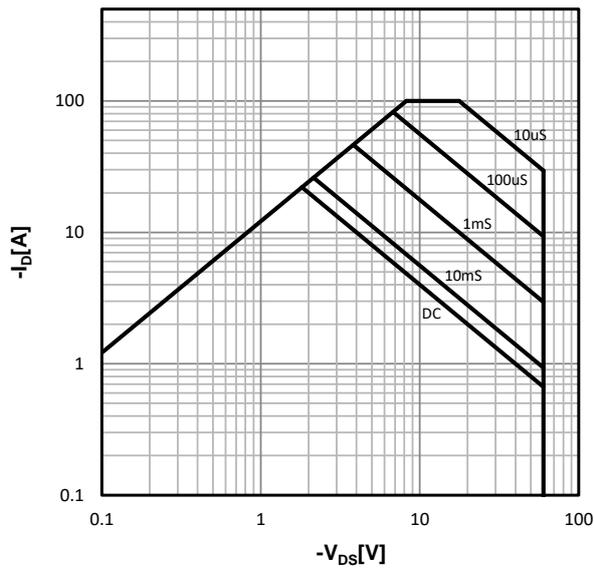
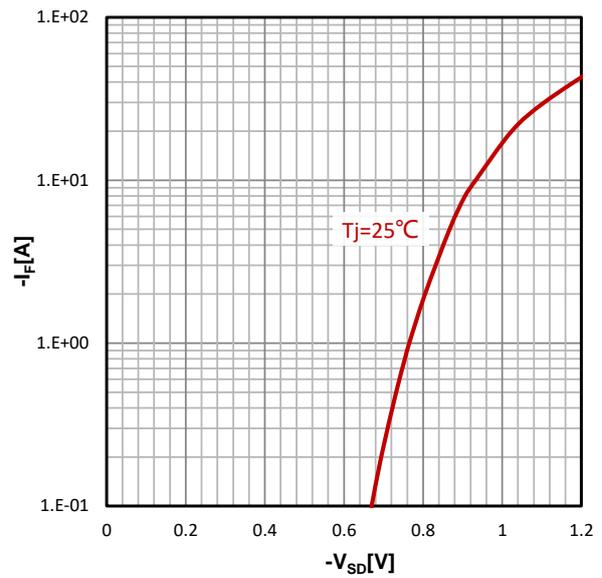


Figure 11: Safe operating area



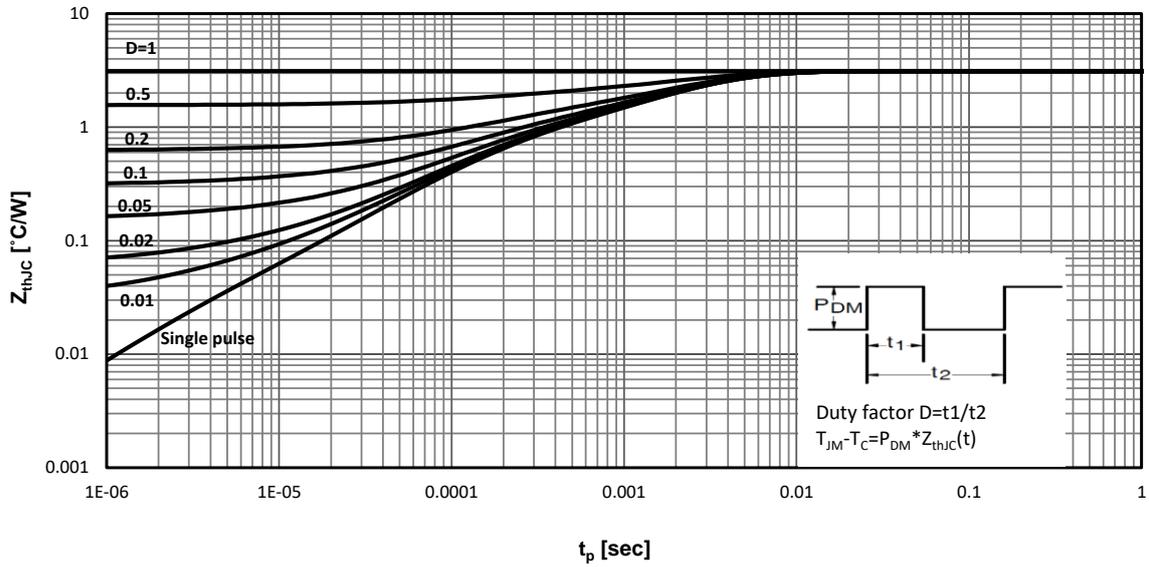
$I_D=f(V_{DS}); T_C=25^{\circ}C; D=0; \text{parameter: } tp$

Figure 12: Typ. forward characteristics



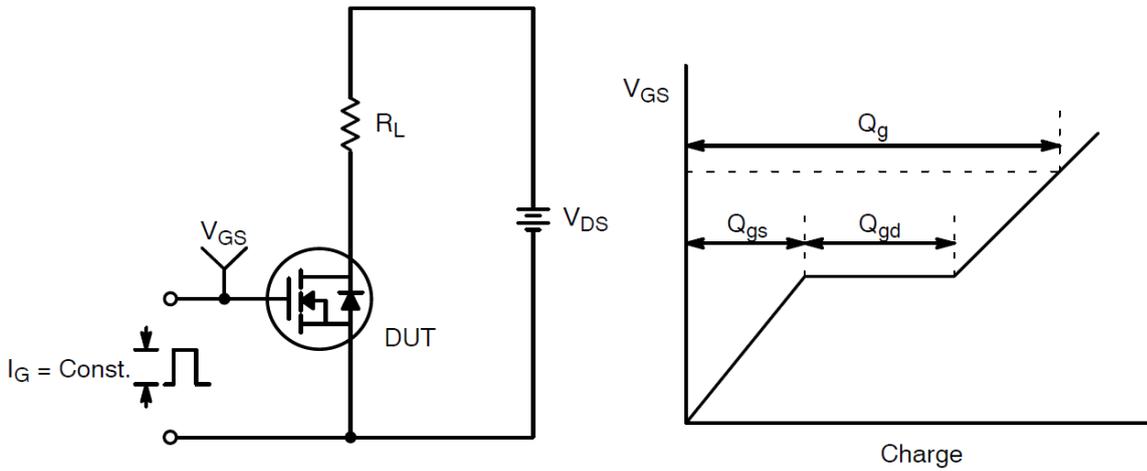
$I_F=f(V_{SD})$

Figure 13: Max. Transient Thermal Impedance

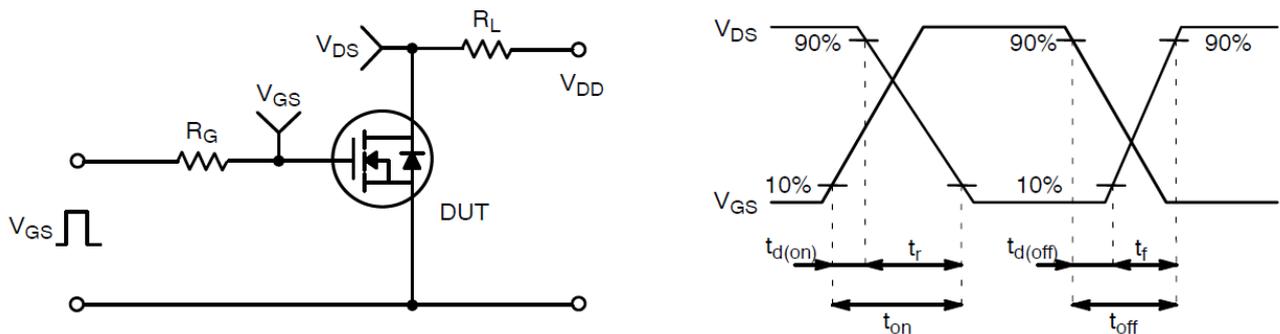


$$Z_{thJC} = f(t_p); \text{ parameter: } D$$

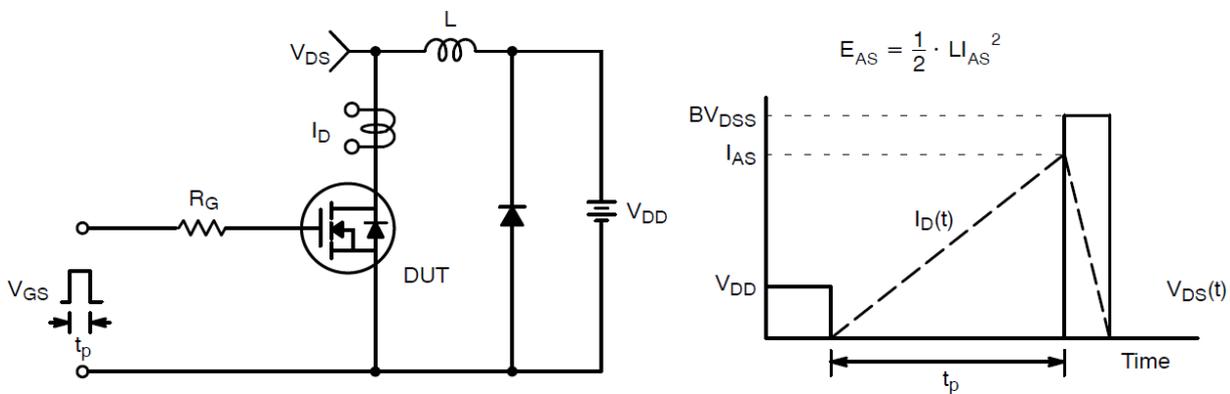
**Test Circuit and Waveform:**



**Gate Charge Test Circuit & Waveform**

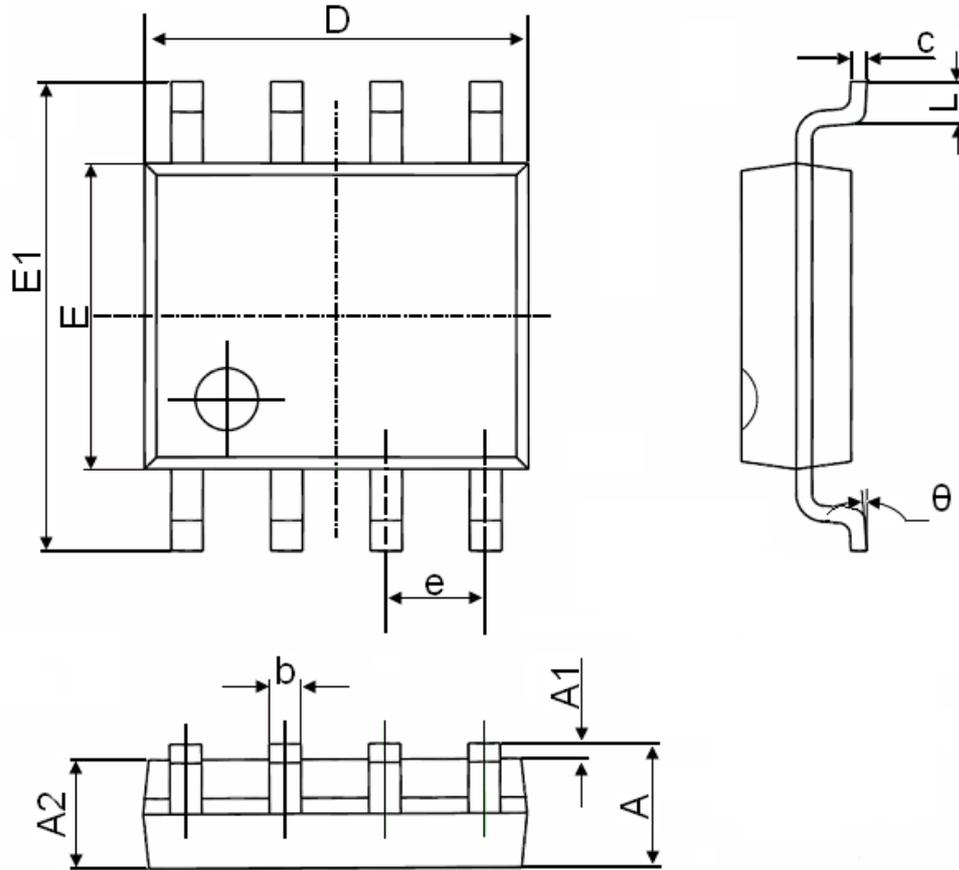


**Resistive Switching Test Circuit & Waveforms**



**Unclamped Inductive Switching Test Circuit & Waveforms**

### Package Mechanical Data- SOP8



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270(BSC)		0.050(BSC)	
L	0.400	1.270	0.016	0.050
θ	0°	8°	0°	8°